# E·XFL



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#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	2 Core, 32-Bit
Speed	1.2GHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR2, DDR3
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.5V, 1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	1023-BFBGA, FCBGA
Supplier Device Package	1023-FCBGA (33x33)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8572lpxatld

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

## NOTE

From a system standpoint, if any of the I/O power supplies ramp prior to the VDD core supply, the I/Os associated with that I/O supply may drive a logic one or zero during power-on reset, and extra current may be drawn by the device.

# **3** Power Characteristics

The estimated typical power dissipation for the core complex bus (CCB) versus the core frequency for this family of PowerQUICC III devices with out the L in its part ordering is shown in Table 4.

CCB Frequency	Core Frequency	Typical-65 <sup>2</sup>	Typical-105 <sup>3</sup>	Maximum <sup>4</sup>	Unit
533	1067	12.3	17.8	18.5	W
533	1200	12.3	17.8	18.5	W
533	1333	16.3	22.8	24.5	W
600	1500	17.3	23.9	25.9	W

Table 4	MPC8572F	Power	Dissir	nation <sup>1</sup>
		I OWEI	Diagih	Jation

Notes:

<sup>1</sup> This reflects the MPC8572E power dissipation excluding the power dissipation from B/G/L/O/T/XV<sub>DD</sub> rails.

 $^2~$  Typical-65 is based on V\_DD = 1.1 V, T\_j = 65 °C, running Dhrystone.

<sup>3</sup> Typical-105 is based on  $V_{DD}$  = 1.1 V,  $T_i$  = 105 °C, running Dhrystone.

<sup>4</sup> Maximum is based on  $V_{DD}$  = 1.1 V,  $T_j$  = 105 °C, running a smoke test.

The estimated typical power dissipation for the core complex bus (CCB) versus the core frequency for this family of PowerQUICC III devices with the L in its port ordering is shown in Table 5.

CCB Frequency	Core Frequency	Typical-65 <sup>2</sup>	Typical-105 <sup>3</sup>	Maximum <sup>4</sup>	Unit
533	1067	12	15	15.8	W
533	1200	12	15.5	16.3	W
533	1333	12	15.9	16.9	W
600	1500	13	18.7	20.0	W

Table 5. MPC8572EL Power Dissipation <sup>1</sup>

Notes:

<sup>1</sup> This reflects the MPC8572E power dissipation excluding the power dissipation from B/G/L/O/T/XV<sub>DD</sub> rails.

<sup>2</sup> Typical-65 is based on  $V_{DD}$  = 1.1 V, T<sub>j</sub> = 65 °C, running Dhrystone.

<sup>3</sup> Typical-105 is based on V<sub>DD</sub> = 1.1 V,  $T_i$  = 105 °C, running Dhrystone.

 $^4\,$  Maximum is based on V\_{DD} = 1.1 V, T\_i = 105 °C, running a smoke test.



PLL config input setup time with stable SYSCLK before HRESET negation	100	_	μs	
Input setup time for POR configs (other than PLL config) with respect to negation of HRESET	4		SYSCLKs	1
Input hold time for all POR configs (including PLL config) with respect to negation of HRESET	2	_	SYSCLKs	1
Maximum valid-to-high impedance time for actively driven POR configs with respect to negation of HRESET	—	5	SYSCLKs	1

Table 9. RESET Initialization Timing Specifications (continued)

### Notes:

2. Reset assertion timing requirements for DDR3 DRAMs may differ.

## Table 10 provides the PLL lock times.

Table	10.	PLL	Lock	Times
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Parameter/Condition	Symbol	Min	Typical	Max
PLL lock times	_	100	μs	—
Local bus PLL	_	50	μs	_

# 6 DDR2 and DDR3 SDRAM Controller

This section describes the DC and AC electrical specifications for the DDR2 and DDR3 SDRAM controller interface of the MPC8572E. Note that the required  $GV_{DD}(typ)$  voltage is 1.8Vor 1.5 V when interfacing to DDR2 or DDR3 SDRAM, respectively.

# 6.1 DDR2 and DDR3 SDRAM Interface DC Electrical Characteristics

Table 11 provides the recommended operating conditions for the DDR SDRAM controller of the MPC8572E when interfacing to DDR2 SDRAM.

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
I/O supply voltage	GV <sub>DD</sub>	1.71	1.89	V	1
I/O reference voltage	MV <sub>REF</sub> n	$0.49  imes GV_{DD}$	$0.51  imes GV_{DD}$	V	2
I/O termination voltage	V <sub>TT</sub>	MV <sub>REF</sub> <i>n</i> – 0.04	$MV_{REF}n + 0.04$	V	3
Input high voltage	V <sub>IH</sub>	$MV_{REF}n + 0.125$	GV <sub>DD</sub> + 0.3	V	_
Input low voltage	V <sub>IL</sub>	-0.3	MV <sub>REF</sub> n – 0.125	V	_
Output leakage current	I <sub>OZ</sub>	-50	50	μA	4
Output high current (V <sub>OUT</sub> = 1.420 V)	I <sub>OH</sub>	-13.4	_	mA	—

DDDO ODDAM Late	uface DO Electula	- I <b>O</b> le ave et eviletie e	$f_{a,m} = O(1 - (f_{a,m})) = A = O(1)$	,
DURZ SURAW INTE	rtace DU Electric	al Unaracteristics	TOT (= V = (TVD) = T A V	

<sup>1.</sup> SYSCLK is the primary clock input for the MPC8572E.



Ethernet: Enhanced Three-Speed Ethernet (eTSEC)

The Fast Ethernet Controller (FEC) operates in MII mode only, and complies with the AC and DC electrical characteristics specified in this chapter for MII. Note that if FEC is used, eTSEC 3 and 4 are only available in SGMII mode.

## 8.1.1 eTSEC DC Electrical Characteristics

All MII, GMII, RMII, and TBI drivers and receivers comply with the DC parametric attributes specified in Table 23 and Table 24. All RGMII, RTBI and FIFO drivers and receivers comply with the DC parametric attributes specified in Table 24. The RGMII and RTBI signals are based on a 2.5-V CMOS interface voltage as defined by JEDEC EIA/JESD8-5.

Parameter	Symbol	Min	Max	Unit	Notes
Supply voltage 3.3 V	LV <sub>DD</sub> TV <sub>DD</sub>	3.13	3.47	V	1, 2
Output high voltage $(LV_{DD}/TV_{DD} = Min, IOH = -4.0 mA)$	VOH	2.40	LV <sub>DD</sub> /TV <sub>DD</sub> + 0.3	V	—
Output low voltage $(LV_{DD}/TV_{DD} = Min, IOL = 4.0 mA)$	VOL	GND	0.50	V	—
Input high voltage	V <sub>IH</sub>	2.0	$LV_{DD}/TV_{DD} + 0.3$	V	—
Input low voltage	V <sub>IL</sub>	-0.3	0.90	V	—
Input high current $(V_{IN} = LV_{DD}, V_{IN} = TV_{DD})$	IIH	_	40	μΑ	1, 2,3
Input low current (V <sub>IN</sub> = GND)	Ι <sub>ΙL</sub>	-600	_	μA	3

Table 23.	GMII.	MII. RMII.	and TBI DC	Electrical	Characteristics
	<b>.</b> ,	,		Liootiioui	0114140101101100

## Notes:

<sup>1</sup> LV<sub>DD</sub> supports eTSECs 1 and 2.

 $^{2}$  TV<sub>DD</sub> supports eTSECs 3 and 4 or FEC.

 $^{3}$  The symbol V<sub>IN</sub>, in this case, represents the LV<sub>IN</sub> and TV<sub>IN</sub> symbols referenced in Table 1.

## Table 24. MII, GMII, RMII, RGMII, TBI, RTBI, and FIFO DC Electrical Characteristics

Parameters	Symbol	Min	Мах	Unit	Notes
Supply voltage 2.5 V	LV <sub>DD/</sub> TV <sub>DD</sub>	2.37	2.63	V	1,2
Output high voltage ( $LV_{DD}/TV_{DD} = Min, IOH = -1.0 mA$ )	V <sub>OH</sub>	2.00	$LV_{DD}/TV_{DD} + 0.3$	V	—
Output low voltage $(LV_{DD}/TV_{DD} = Min, I_{OL} = 1.0 mA)$	V <sub>OL</sub>	GND – 0.3	0.40	V	—
Input high voltage	V <sub>IH</sub>	1.70	$LV_{DD}/TV_{DD} + 0.3$	V	—
Input low voltage	V <sub>IL</sub>	-0.3	0.70	V	—



Table 25. FIFO Mode Transmit AC Timing Specification (continued)

At recommended operating conditions with LV\_{DD}/TV\_{DD} of 2.5V  $\pm\,5\%$ 

Parameter/Condition	Symbol	Min	Тур	Мах	Unit
TX_CLK, GTX_CLK peak-to-peak jitter	t <sub>FITJ</sub>	—	_	250	ps
Rise time TX_CLK (20%–80%)	t <sub>FITR</sub>	—	_	0.75	ns
Fall time TX_CLK (80%–20%)	t <sub>FITF</sub>	—	_	0.75	ns
FIFO data TXD[7:0], TX_ER, TX_EN setup time to GTX_CLK	t <sub>FITDV</sub>	2.0	_	_	ns
GTX_CLK to FIFO data TXD[7:0], TX_ER, TX_EN hold time	t <sub>FITDX</sub>	0.5	_	3.0	ns

Notes:

1. The minimum cycle period (or maximum frequency) of the TX\_CLK is dependent on the maximum platform frequency of the speed bins the part belongs to as well as the FIFO mode under operation. Refer to Section 4.5, "Platform to eTSEC FIFO Restrictions," for more detailed description.

## Table 26. FIFO Mode Receive AC Timing Specification

At recommended operating conditions with  $LV_{DD}/TV_{DD}$  of 2.5V ± 5%

Parameter/Condition	Symbol	Min	Тур	Мах	Unit
RX_CLK clock period <sup>1</sup>	t <sub>FIR</sub>	5.3	8.0	100	ns
RX_CLK duty cycle	t <sub>FIRH</sub> /t <sub>FIR</sub>	45	50	55	%
RX_CLK peak-to-peak jitter	t <sub>FIRJ</sub>	—	—	250	ps
Rise time RX_CLK (20%–80%)	t <sub>FIRR</sub>	—	—	0.75	ns
Fall time RX_CLK (80%–20%)	t <sub>FIRF</sub>	—	—	0.75	ns
RXD[7:0], RX_DV, RX_ER setup time to RX_CLK	t <sub>FIRDV</sub>	1.5	—	—	ns
RXD[7:0], RX_DV, RX_ER hold time to RX_CLK	t <sub>FIRDX</sub>	0.5	—	—	ns

1. The minimum cycle period (or maximum frequency) of the RX\_CLK is dependent on the maximum platform frequency of the speed bins the part belongs to as well as the FIFO mode under operation. Refer to Section 4.5, "Platform to eTSEC FIFO Restrictions," for more detailed description.

Figure 7 and Figure 8 show the FIFO timing diagrams.



Figure 7. FIFO Transmit AC Timing Diagram

Ethernet: Enhanced Three-Speed Ethernet (eTSEC)



Figure 8. FIFO Receive AC Timing Diagram

## 8.2.2 GMII AC Timing Specifications

This section describes the GMII transmit and receive AC timing specifications.

## 8.2.2.1 GMII Transmit AC Timing Specifications

Table 27 provides the GMII transmit AC timing specifications.

## Table 27. GMII Transmit AC Timing Specifications

At recommended operating conditions with  $LV_{DD}/TV_{DD}$  of 2.5/ 3.3 V ± 5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Мах	Unit
GMII data TXD[7:0], TX_ER, TX_EN setup time	t <sub>GTKHDV</sub>	2.5	—	_	ns
GTX_CLK to GMII data TXD[7:0], TX_ER, TX_EN delay	<sup>t</sup> GTKHDX	0.5	—	5.0	ns
GTX_CLK data clock rise time (20%-80%)	t <sub>GTXR</sub> <sup>2</sup>	—	—	1.0	ns
GTX_CLK data clock fall time (80%-20%)	t <sub>GTXF</sub> 2	—	—	1.0	ns

#### Notes:

1. The symbols used for timing specifications herein follow the pattern t<sub>(first two letters of functional block)(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>GTKHDV</sub> symbolizes GMII transmit timing (GT) with respect to the t<sub>GTX</sub> clock reference (K) going to the high state (H) relative to the time date input signals (D) reaching the valid state (V) to state or setup time. Also, t<sub>GTKHDX</sub> symbolizes GMII transmit timing (GT) with respect to the high state (H) relative to the time date input signals (D) going invalid (X) or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>GTX</sub> represents the GMII(G) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).</sub>

2. Guaranteed by design.



Figure 12 shows the MII transmit AC timing diagram.



Figure 12. MII Transmit AC Timing Diagram

## 8.2.3.2 MII Receive AC Timing Specifications

Table 30 provides the MII receive AC timing specifications.

Table 30. MII Receive AC Timing Specifications

At recommended operating conditions with LV\_{DD}/TV\_{DD} of 2.5/ 3.3 V ± 5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Мах	Unit
RX_CLK clock period 10 Mbps	t <sub>MRX</sub> <sup>2</sup>	—	400	—	ns
RX_CLK clock period 100 Mbps	t <sub>MRX</sub>	—	40	—	ns
RX_CLK duty cycle	t <sub>MRXH</sub> /t <sub>MRX</sub>	35	—	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t <sub>MRDVKH</sub>	10.0	—	—	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t <sub>MRDXKH</sub>	10.0	—	—	ns
RX_CLK clock rise (20%-80%)	t <sub>MRXR</sub> <sup>2</sup>	1.0	—	4.0	ns
RX_CLK clock fall time (80%-20%)	t <sub>MRXF</sub> <sup>2</sup>	1.0	—	4.0	ns

Notes:

1. The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MRDVKH</sub> symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MRX</sub> clock reference</sub>

receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>MRDXKL</sub> symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>MRX</sub> clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>MRX</sub> represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

2. Guaranteed by design.

Figure 13 provides the AC test load for eTSEC.



Figure 13. eTSEC AC Test Load



### Table 35. RMII Transmit AC Timing Specifications (continued)

At recommended operating conditions with LV\_{DD}/TV\_{DD} of 2.5/ 3.3 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Мах	Unit
TSECn_TX_CLK to RMII data TXD[1:0], TX_EN delay	t <sub>RMTDX</sub>	1.0	—	10.0	ns

Note:

1. The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>MTKHDX</sub> symbolizes MII transmit timing (MT) for the time t<sub>MTX</sub> clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t<sub>MTX</sub> represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).</sub>

Figure 19 shows the RMII transmit AC timing diagram.



Figure 19. RMII Transmit AC Timing Diagram

## 8.2.7.2 RMII Receive AC Timing Specifications

Table 36 shows the RMII receive AC timing specifications.

## Table 36. RMII Receive AC Timing Specifications

At recommended operating conditions with LV<sub>DD</sub>/TV<sub>DD</sub> of 2.5/ 3.3 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Max	Unit
TSECn_TX_CLK clock period	t <sub>RMR</sub>	15.0	20.0	25.0	ns
TSECn_TX_CLK duty cycle	t <sub>RMRH</sub>	35	50	65	%
TSECn_TX_CLK peak-to-peak jitter	t <sub>RMRJ</sub>	_	_	250	ps
Rise time TSECn_TX_CLK (20%-80%)	t <sub>RMRR</sub>	1.0	—	2.0	ns
Fall time TSECn_TX_CLK (80%–20%)	t <sub>RMRF</sub>	1.0	—	2.0	ns
RXD[1:0], CRS_DV, RX_ER setup time to TSECn_TX_CLK rising edge	t <sub>RMRDV</sub>	4.0	_	—	ns



#### **Ethernet Management Interface Electrical Characteristics**

## Table 45. MII Management AC Timing Specifications (continued)

At recommended operating conditions with  $LV_{DD}/TV_{DD}$  of 3.3 V ± 5% or 2.5 V ± 5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Мах	Unit	Notes
ECn_MDIO to ECn_MDC setup time	t <sub>MDDVKH</sub>	5	—	-	ns	_
ECn_MDIO to ECn_MDC hold time	t <sub>MDDXKH</sub>	0	—	-	ns	_
ECn_MDC rise time	t <sub>MDCR</sub>	-	—	10	ns	4
ECn_MDC fall time	t <sub>MDHF</sub>	—	—	10	ns	4

### Notes:

1. The symbols used for timing specifications herein follow the pattern of t(first two letters of functional block)(signal)(state)

(reference)(state) for inputs and  $t_{(first two letters of functional block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{MDKHDX}$  symbolizes management data timing (MD) for the time  $t_{MDC}$  from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also,  $t_{MDDVKH}$  symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{MDC}$  clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

- 2. This parameter is dependent on the eTSEC system clock speed, which is half of the Platform Frequency ( $f_{CCB}$ ). The actual ECn\_MDC output clock frequency for a specific eTSEC port can be programmed by configuring the MgmtClk bit field of MPC8572E's MIIMCFG register, based on the platform (CCB) clock running for the device. The formula is: Platform Frequency (CCB)/(2\*Frequency Divider determined by MIICFG[MgmtClk] encoding selection). For example, if MIICFG[MgmtClk] = 000 and the platform (CCB) is currently running at 533 MHz,  $f_{MDC} = 533/(2*4*8) = 533/64 = 8.3$  MHz. That is, for a system running at a particular platform frequency ( $f_{CCB}$ ), the ECn\_MDC output clock frequency can be programmed between maximum  $f_{MDC} = f_{CCB}/64$  and minimum  $f_{MDC} = f_{CCB}/448$ . Refer to MPC8572E reference manual's MIIMCFG register section for more detail.
- 3. The maximum ECn\_MDC output clock frequency is defined based on the maximum platform frequency for MPC8572E (600 MHz) divided by 64, while the minimum ECn\_MDC output clock frequency is defined based on the minimum platform frequency for MPC8572E (400 MHz) divided by 448, following the formula described in Note 2 above. The typical ECn\_MDC output clock frequency of 2.5 MHz is shown for reference purpose per IEEE 802.3 specification.
- 4. Guaranteed by design.
- 5. t<sub>plb clk</sub> is the platform (CCB) clock.

Figure 28 shows the MII management AC timing diagram.



Figure 28. MII Management Interface Timing Diagram

# NP

#### Local Bus Controller (eLBC)

Table 50. Local Bus General Timing Parameters ( $BV_{DD} = 2.5 V DC$ )—PLL Enabled (continued)At recommended operating conditions with  $BV_{DD}$  of 2.5 V ± 5% (continued)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus clock to output valid (except LAD/LDP and LALE)	t <sub>LBKHOV1</sub>	—	2.4	ns	_
Local bus clock to data valid for LAD/LDP	t <sub>LBKHOV2</sub>	—	2.5	ns	3
Local bus clock to address valid for LAD	t <sub>LBKHOV3</sub>	—	2.4	ns	3
Local bus clock to LALE assertion	t <sub>LBKHOV4</sub>	—	2.4	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	t <sub>LBKHOX1</sub>	0.8	—	ns	3
Output hold from local bus clock for LAD/LDP	t <sub>LBKHOX2</sub>	0.8	—	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	t <sub>LBKHOZ1</sub>	_	2.6	ns	5
Local bus clock to output high impedance for LAD/LDP	t <sub>LBKHOZ2</sub>	—	2.6	ns	5

Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(First two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(First two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>LBIXKH1</sub> symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t<sub>LBK</sub> clock reference (K) goes high (H), in this case for clock one(1). Also, t<sub>LBKHOX</sub> symbolizes local bus timing (LB) for the t<sub>LBK</sub> clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
- 2. All timings are in reference to LSYNC\_IN for PLL enabled and internal local bus clock for PLL bypass mode.
- 3. All signals are measured from  $BV_{DD}/2$  of the rising edge of LSYNC\_IN for PLL enabled or internal local bus clock for PLL bypass mode to  $0.4 \times BV_{DD}$  of the signal in question for 2.5-V signaling levels.
- 4. Input timings are measured at the pin.
- 5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 6. t<sub>LBOTOT</sub> is a measurement of the minimum time between the negation of LALE and any change in LAD. t<sub>LBOTOT</sub> is programmed with the LBCR[AHD] parameter.
- 7. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at BV<sub>DD</sub>/2.
- 8. Guaranteed by design.

Table 51 describes the general timing parameters of the local bus interface at  $BV_{DD} = 1.8 \text{ V DC}$ 

Table 51. Local Bus General Timing Parameters ( $BV_{DD} = 1.8 \text{ V DC}$ )—PLL Enabled At recommended operating conditions with  $BV_{DD}$  of 1.8 V ± 5%

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus cycle time	t <sub>LBK</sub>	6.67	12	ns	2
Local bus duty cycle	t <sub>LBKH/</sub> t <sub>LBK</sub>	43	57	%	—
LCLK[n] skew to LCLK[m] or LSYNC_OUT	t <sub>LBKSKEW</sub>	—	150	ps	7, 8
Input setup to local bus clock (except LGTA/LUPWAIT)	t <sub>LBIVKH1</sub>	2.4	—	ns	3, 4
LGTA/LUPWAIT input setup to local bus clock	t <sub>LBIVKH2</sub>	1.9	—	ns	3, 4
Input hold from local bus clock (except LGTA/LUPWAIT)	t <sub>LBIXKH1</sub>	1.1	—	ns	3, 4



Local Bus Controller (eLBC)



Figure 35. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 8 or 16 (PLL Bypass Mode)

1<sup>2</sup>C

## Table 54. I<sup>2</sup>C DC Electrical Characteristics (continued)

Capacitance for each I/O pin	CI		10	pF	

## Notes:

1. Output voltage (open drain or open collector) condition = 3 mA sink current.

2. Refer to the MPC8572E PowerQUICC<sup>™</sup> III Integrated Host Processor Family Reference Manual for information on the digital filter used.

3. I/O pins will obstruct the SDA and SCL lines if  $\mathsf{OV}_\mathsf{DD}$  is switched off.

# 13.2 I<sup>2</sup>C AC Electrical Specifications

Table 55 provides the AC timing parameters for the  $I^2C$  interfaces.

## Table 55. I<sup>2</sup>C AC Electrical Specifications

At recommended operating conditions with  $OV_{DD}$  of 3.3 V ± 5%. All values refer to  $V_{IH}$  (min) and  $V_{IL}$  (max) levels (see Table 2).

Parameter	Symbol <sup>1</sup>	Min	Max	Unit
SCL clock frequency	f <sub>I2C</sub>	0	400	kHz <sup>4</sup>
Low period of the SCL clock	t <sub>I2CL</sub>	1.3	_	μs
High period of the SCL clock	t <sub>I2CH</sub>	0.6	_	μs
Setup time for a repeated START condition	t <sub>I2SVKH</sub>	0.6		μs
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t <sub>I2SXKL</sub>	0.6	—	μs
Data setup time	t <sub>I2DVKH</sub>	100	_	ns
Data input hold time: CBUS compatible masters I <sup>2</sup> C bus devices	t <sub>i2DXKL</sub>	$\overline{0^2}$		μs
Data output delay time	t <sub>I2OVKL</sub>	—	0.9 <sup>3</sup>	μs
Setup time for STOP condition	t <sub>I2PVKH</sub>	0.6	—	μs
Bus free time between a STOP and START condition	t <sub>I2KHDX</sub>	1.3	—	μs
Noise margin at the LOW level for each connected device (including hysteresis)	V <sub>NL</sub>	$0.1 \times OV_{DD}$	—	V
Noise margin at the HIGH level for each connected device (including hysteresis)	V <sub>NH</sub>	$0.2 \times OV_{DD}$	—	V

## High-Speed Serial Interfaces (HSSI)

— To meet the input amplitude requirement, the reference clock inputs might need to be DC or AC-coupled externally. For the best noise performance, the reference of the clock could be DC or AC-coupled into the unused phase (SDn\_REF\_CLK) through the same source impedance as the clock input (SDn\_REF\_CLK) in use.







Figure 46. Differential Reference Clock Input DC Requirements (External AC-Coupled)



Figure 47. Single-Ended Reference Clock Input DC Requirements



# 15.2.3 Interfacing With Other Differential Signaling Levels

- With on-chip termination to SGND\_SRDS*n* (xcorevss), the differential reference clocks inputs are HCSL (High-Speed Current Steering Logic) compatible DC-coupled.
- Many other low voltage differential type outputs like LVDS (Low Voltage Differential Signaling) can be used but may need to be AC-coupled due to the limited common mode input range allowed (100 to 400 mV) for DC-coupled connection.
- LVPECL outputs can produce signal with too large amplitude and may need to be DC-biased at clock driver output first, then followed with series attenuation resistor to reduce the amplitude, additionally to AC-coupling.

## NOTE

Figure 48 to Figure 51 below are for conceptual reference only. Due to the fact that clock driver chip's internal structure, output impedance and termination requirements are different between various clock driver chip manufacturers, it is very possible that the clock circuit reference designs provided by clock driver chip vendor are different from what is shown below. They might also vary from one vendor to the other. Therefore, Freescale Semiconductor can neither provide the optimal clock driver reference circuits, nor guarantee the correctness of the following clock driver connection reference circuits. The system designer is recommended to contact the selected clock driver chip vendor for the optimal reference circuits with the MPC8572E SerDes reference clock receiver requirement provided in this document.





## • Section 17, "Serial RapidIO"

Note that external AC Coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in specification of each protocol section.

# 16 PCI Express

This section describes the DC and AC electrical specifications for the PCI Express bus of the MPC8572E.

# 16.1 <u>DC Requirements</u> for PCI Express SD1\_REF\_CLK and SD1\_REF\_CLK

For more information, see Section 15.2, "SerDes Reference Clocks."

# 16.2 AC Requirements for PCI Express SerDes Reference Clocks

 Table 61 lists AC requirements.

Symbol	Parameter Description	Min	Typical	Max	Units	Notes
t <sub>REF</sub>	REFCLK cycle time	_	10		ns	1
t <sub>REFCJ</sub>	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles	_	_	100	ps	
t <sub>REFPJ</sub>	Phase jitter. Deviation in edge location with respect to mean edge location	-50	—	50	ps	—

## Table 61. SD1\_REF\_CLK and SD1\_REF\_CLK AC Requirements

Notes:

1. Typical cycle time is based on PCI Express Card Electromechanical Specification Revision 1.0a.

# 16.3 Clocking Dependencies

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a +/-300 ppm tolerance.

# 16.4 Physical Layer Specifications

The following is a summary of the specifications for the physical layer of PCI Express on this device. For further details as well as the specifications of the transport and data link layer, Use the PCI Express Base Specification. REV. 1.0a document.

# 16.4.1 Differential Transmitter (TX) Output

Table 62 defines the specifications for the differential output at all transmitters (TXs). The parameters are specified at the component pins.







Figure 59. Single Frequency Sinusoidal Jitter Limits

# 17.7 Receiver Eye Diagrams

For each baud rate at which an LP-Serial receiver is specified to operate, the receiver shall meet the corresponding Bit Error Rate specification (Table 72, Table 73, and Table 74) when the eye pattern of the receiver test signal (exclusive of sinusoidal jitter) falls entirely within the unshaded portion of the Receiver Input Compliance Mask shown in Figure 60 with the parameters specified in Table 75. The eye pattern of the receiver test signal is measured at the input pins of the receiving device with the device replaced with a 100- $\Omega$  +/– 5% differential resistive load.



Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes	
D1_MCAS	Column Address Strobe	AC9	0	GV <sub>DD</sub>		
D1_MRAS	Row Address Strobe	AB12	0	GV <sub>DD</sub>		
D1_MCKE[0:3]	Clock Enable	M8, L9, T9, N8	0	GV <sub>DD</sub>	11	
D1_MCS[0:3]	Chip Select	AB9, AF10, AB11, AE11	0	GV <sub>DD</sub>	_	
D1_MCK[0:5]	Clock	V7, E13, AH11, Y9, F14, AG10	0	GV <sub>DD</sub>		
D1_MCK[0:5]	Clock Complements	Y10, E12, AH12, AA11, F13, AG11	0	GV <sub>DD</sub>		
D1_MODT[0:3]	On Die Termination	AD10, AF12, AC10, AE12	0	GV <sub>DD</sub>	_	
D1_MDIC[0:1]	Driver Impedance Calibration	E15, G14	I/O	GV <sub>DD</sub>	25	
DDR SDRAM Memory Interface 2						
D2_MDQ[0:63]	Data	A6, B7, C5, D5, A7, C8, D8, D6, C4, A3, D3, D2, B4, A4, B1, C1, E3, E1, G2, G6, D1, E4, G5, G3, J4, J2, P4, R5, H3, H1, N5, N3, Y6, Y4, AC3, AD2, V5, W5, AB2, AB3, AD5, AE3, AF6, AG7, AC4, AD4, AF4, AF7, AH5, AJ1, AL2, AM3, AH3, AH6, AM1, AL3, AK5, AL5, AJ7, AK7, AK4, AM4, AL6, AM7	I/O	GV <sub>DD</sub>	_	
D2_MECC[0:7]	Error Correcting Code	J5, H7, L7, N6, H4, H6, M4, M5	I/O	GV <sub>DD</sub>		
D2_MAPAR_ERR	Address Parity Error	N1	Ι	GV <sub>DD</sub>		
D2_MAPAR_OUT	Address Parity Out	W2	0	GV <sub>DD</sub>		
D2_MDM[0:8]	Data Mask	A5, B3, F4, J1, AA4, AE5, AK1, AM5, K5	0	GV <sub>DD</sub>		
D2_MDQS[0:8]	Data Strobe	B6, C2, F5, L4, AB5, AF3, AL1, AM6, L6	I/O	GV <sub>DD</sub>	_	
D2_MDQS[0:8]	Data Strobe	C7, A2, F2, K3, AA5, AE6, AK2, AJ6, K6	I/O	GV <sub>DD</sub>	_	
D2_MA[0:15]	Address	W1, U4, U3, T1, T2, T3, R1, R2, T5, R4, Y3, P1, N2, AF1, M2, M1	0	GV <sub>DD</sub>	_	

## Table 76. MPC8572E Pinout Listing (continued)



Package Description

Table 76. MPC8572E Pinout Listing (continue	d)
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Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
D2_MBA[0:2]	Bank Select	Y1, W3, P3	0	GV <sub>DD</sub>	_
D2_MWE	Write Enable	AA2	0	GV <sub>DD</sub>	_
D2_MCAS	Column Address Strobe	AD1	0	GV <sub>DD</sub>	_
D2_MRAS	Row Address Strobe	AA1	0	GV <sub>DD</sub>	_
D2_MCKE[0:3]	Clock Enable	L3, L1, K1, K2	0	GV <sub>DD</sub>	11
D2_MCS[0:3]	Chip Select	AB1, AG2, AC1, AH2	0	GV <sub>DD</sub>	_
D2_MCK[0:5]	Clock	V4, F7, AJ3, V2, E7, AG4	0	GV <sub>DD</sub>	—
D2_MCK[0:5]	Clock Complements	V1, F8, AJ4, U1, E6, AG5	0	GV <sub>DD</sub>	—
D2_MODT[0:3]	On Die Termination	AE1, AG1, AE2, AH1	0	GV <sub>DD</sub>	_
D2_MDIC[0:1]	Driver Impedance Calibration	F1, G1	I/O	GV <sub>DD</sub>	25
	Local Bus Contro	ller Interface			
LAD[0:31]	Muxed Data/Address	M22, L22, F22, G22, F21, G21, E20, H22, K22, K21, H19, J20, J19, L20, M20, M19, E22, E21, L19, K19, G19, H18, E18, G18, J17, K17, K14, J15, H16, J14, H15, G15	I/O	BV <sub>DD</sub>	34
LDP[0:3]	Data Parity	M21, D22, A24, E17	I/O	BV <sub>DD</sub>	_
LA[27]	Burst Address	J21	0	BV <sub>DD</sub>	5, 9
LA[28:31]	Port Address	F20, K18, H20, G17	0	BV <sub>DD</sub>	5, 7, 9
LCS[0:4]	Chip Selects	B23, E16, D20, B25, A22	0	BV <sub>DD</sub>	10
LCS[5]/DMA2_DREQ[1]	Chip Selects / DMA Request	D19	I/O	BV <sub>DD</sub>	1, 10
LCS[6]/DMA2_DACK[1]	Chip Selects / DMA Ack	E19	0	BV <sub>DD</sub>	1, 10
LCS[7]/DMA2_DDONE[1]	Chip Selects / DMA Done	C21	0	BV <sub>DD</sub>	1, 10
LWE[0]/LBS[0]/LFWE	Write Enable / Byte Select	D17	0	BV <sub>DD</sub>	5, 9
LWE[1]/LBS[1]	Write Enable / Byte Select	F15	0	BV <sub>DD</sub>	5, 9
LWE[2]/LBS[2]	Write Enable / Byte Select	B24	0	BV <sub>DD</sub>	5, 9
LWE[3]/LBS[3]	Write Enable / Byte Select	D18	0	BV <sub>DD</sub>	5, 9
LALE	Address Latch Enable	F19	0	BV <sub>DD</sub>	5, 8, 9
LBCTL	Buffer Control	L18	0	BV <sub>DD</sub>	5, 8, 9



**Package Description** 

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
N/C	No Connection	A16, A20, B16, B17, B19, B20, C17, C18, C19, D28, R31, T17, V23, W23, Y22, Y23, Y24, AA24, AB24, AC24, AC26, AC27, AC29, AD31, AE29, AJ25, AK28, AL31, AM21	_		17

## Table 76. MPC8572E Pinout Listing (continued)

#### Note:

- 1. All multiplexed signals are listed only once and do not re-occur. For example, LCS5/DMA\_REQ2 is listed only once in the local bus controller section, and is not mentioned in the DMA section even though the pin also functions as DMA\_REQ2.
- 2. Recommend a weak pull-up resistor (2–10 K $\Omega$ ) be placed on this pin to OVDD.
- 4. This pin is an open drain signal.
- 5. This pin is a reset configuration pin. It has a weak internal pull-up P-FET which is enabled only when the processor is in the reset state. This pull-up is designed such that it can be overpowered by an external 4.7-kO pull-down resistor. However, if the signal is intended to be high after reset, and if there is any device on the net which might pull down the value of the net at reset, then a pullup or active driver is needed.
- 6. Treat these pins as no connects (NC) unless using debug address functionality.
- 7. The value of LA[29:31] during reset sets the CCB clock to SYSCLK PLL ratio. These pins require 4.7-kΩ pull-up or pull-down resistors. See Section 19.2, "CCB/SYSCLK PLL Ratio."
- 8. The value of LALE, LGPL2 and LBCTL at reset set the e500 core clock to CCB Clock PLL ratio. These pins require 4.7-kΩ pull-up or pull-down resistors. See the Section 19.3, "e500 Core PLL Ratio."
- 9. Functionally, this pin is an output, but structurally it is an I/O because it either samples configuration input during reset or because it has other manufacturing test functions. This pin therefore be described as an I/O for boundary scan.
- 10. If this pin is configured for local bus controller usage, recommend a weak pull-up resistor (2-10 K $\Omega$ ) be placed on this pin to BVDD, to ensure no random chip select assertion due to possible noise and so on.
- 11. This output is actively driven during reset rather than being three-stated during reset.
- 12. These JTAG pins have weak internal pull-up P-FETs that are always enabled.
- 13. These pins are connected to the VDD/GND planes internally and may be used by the core power supply to improve tracking and regulation.
- 14. Internal thermally sensitive diode.
- 15. If this pin is connected to a device that pulls down during reset, an external pull-up is required to drive this pin to a safe state during reset.
- 16. This pin is only an output in FIFO mode when used as Rx Flow Control.
- 17. Do not connect.
- 18. These are test signals for factory use only and must be pulled up (100  $\Omega$  1 K $\Omega$ ) to OVDD for normal machine operation.
- 19. Independent supplies derived from board VDD.
- 20. Recommend a pull-up resistor (~1 K $\Omega$ ) be placed on this pin to OVDD.
- 21. The following pins must NOT be pulled down during power-on reset: DMA1\_DACK[0:1], EC5\_MDC, HRESET\_REQ, TRIG\_OUT/READY\_P0/QUIESCE, MSRCID[2:4], MDVAL, ASLEEP.
- 22. This pin requires an external 4.7-kΩ pull-down resistor to prevent PHY from seeing a valid Transmit Enable before it is actively driven.
- 23. This pin is only an output in eTSEC3 FIFO mode when used as Rx flow control.
- 24. TSEC2\_TXD[1] is used as cfg\_dram\_type. IT MUST BE VALID AT POWER-UP, EVEN BEFORE HRESET ASSERTION.



# 21 System Design Information

This section provides electrical and thermal design recommendations for successful application of the MPC8572E.

# 21.1 System Clocking

The platform PLL generates the platform clock from the externally supplied SYSCLK input. The frequency ratio between the platform and SYSCLK is selected using the platform PLL ratio configuration bits as described in Section 19.2, "CCB/SYSCLK PLL Ratio." The MPC8572E includes seven PLLs, with the following functions:

- Two core PLLs have ratios that are individually configurable. Each e500 core PLL generates the core clock as a slave to the platform clock. The frequency ratio between the e500 core clock and the platform clock is selected using the e500 PLL ratio configuration bits as described in Section 19.3, "e500 Core PLL Ratio."
- The DDR complex PLL generates the clocking for the DDR controllers.
- The local bus PLL generates the clock for the local bus.
- The PLL for the SerDes1 module is used for PCI Express and Serial Rapid IO interfaces.
- The PLL for the SerDes2 module is used for the SGMII interface.

# 21.2 Power Supply Design

## 21.2.1 PLL Power Supply Filtering

Each of the PLLs listed above is provided with power through independent power supply pins  $(AV_{DD}PLAT, AV_{DD}CORE0, AV_{DD}CORE1, AV_{DD}DDR, AV_{DD}LBIU, AV_{DD}SRDS1 and AV_{DD}SRDS2 respectively).$  The AV<sub>DD</sub> level should always be equivalent to V<sub>DD</sub>, and preferably these voltages are derived directly from V<sub>DD</sub> through a low frequency filter scheme such as the following.

There are a number of ways to reliably provide power to the PLLs, but the recommended solution is to provide independent filter circuits per PLL power supply as illustrated in Figure 62, one to each of the  $AV_{DD}$  pins. By providing independent filters to each PLL the opportunity to cause noise injection from one PLL to the other is reduced.

This circuit is intended to filter noise in the PLLs resonant frequency range from a 500 kHz to 10 MHz range. It should be built with surface mount capacitors with minimum Effective Series Inductance (ESL). Consistent with the recommendations of Dr. Howard Johnson in *High Speed Digital Design: A Handbook of Black Magic* (Prentice Hall, 1993), multiple small capacitors of equal value are recommended over a single large value capacitor.

Each circuit should be placed as close as possible to the specific  $AV_{DD}$  pin being supplied to minimize noise coupled from nearby circuits. It should be possible to route directly from the capacitors to the  $AV_{DD}$  pin, which is on the periphery of the 1023 FC-PBGA footprint, without the inductance of vias.



#### System Design Information

logic does not interfere with normal chip operation. While the TAP controller can be forced to the reset state using only the TCK and TMS signals, generally systems assert TRST during the power-on reset flow. Simply tying TRST to HRESET is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP), which implements the debug interface to the chip.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert HRESET or TRST to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in Figure 66 allows the COP port to independently assert  $\overline{\text{HRESET}}$  or  $\overline{\text{TRST}}$ , while ensuring that the target can drive  $\overline{\text{HRESET}}$  as well.

The COP interface has a standard header, shown in Figure 65, for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; so emulator vendors have issued many different pin numbering schemes. Some COP headers are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom. Still others number the pins counter-clockwise from pin 1 (as with an IC). Regardless of the numbering scheme, the signal placement recommended in Figure 65 is common to all known emulators.

## 21.9.1 Termination of Unused Signals

If the JTAG interface and COP header is not used, Freescale recommends the following connections:

- TRST should be tied to HRESET through a 0 k $\Omega$  isolation resistor so that it is asserted when the system reset signal (HRESET) is asserted, ensuring that the JTAG scan chain is initialized during the power-on reset flow. Freescale recommends that the COP header be designed into the system as shown in Figure 66. If this is not possible, the isolation resistor allows future access to TRST in case a JTAG interface may need to be wired onto the system in future debug situations.
- No pull-up/pull-down is required for TDI, TMS, TDO or TCK.